

# SIEMENS

## DUAL CHANNEL ILD621/621GB QUAD CHANNEL ILQ621/621GB MULTI-CHANNEL PHOTOTRANSISTOR OPTOCOUPLER

### FEATURES

- Alternate Source to TLP621-2/-4 and TLP621GB-2/-4
- Current Transfer Ratio (CTR) at  $I_F = 5 \text{ mA}$   
ILD/Q621: 50% Min.  
ILD/Q621GB: 100% Min.
- Saturated Current Transfer Ratio ( $CTR_{SAT}$ ) at  $I_F = 1 \text{ mA}$   
ILD/Q621: 60% Typ.  
ILD/Q621GB: 30% Min.
- High Collector-Emitter Voltage,  $BV_{CEO} = 70 \text{ V}$
- Dual and Quad Packages Feature:
  - Reduced Board Space
  - Lower Pin and Parts Count
  - Better Channel to Channel CTR Match
  - Improved Common Mode Rejection
- Field-Effect Stable by TRIOS (TRansparent IOn Shield)
- Isolation Test Voltage from Double Molded Package, 5300 VAC<sub>RMS</sub>
- Underwriters Lab File #E52744
- VDE 0884 Available with Option 1

### Maximum Ratings (Each Channel)

#### Emitter

Reverse Voltage .....	6 V
Forward Current .....	60 mA
Surge Current .....	1.5 A
Power Dissipation.....	100 mW
Derate from 25°C .....	1.33 mW/°C

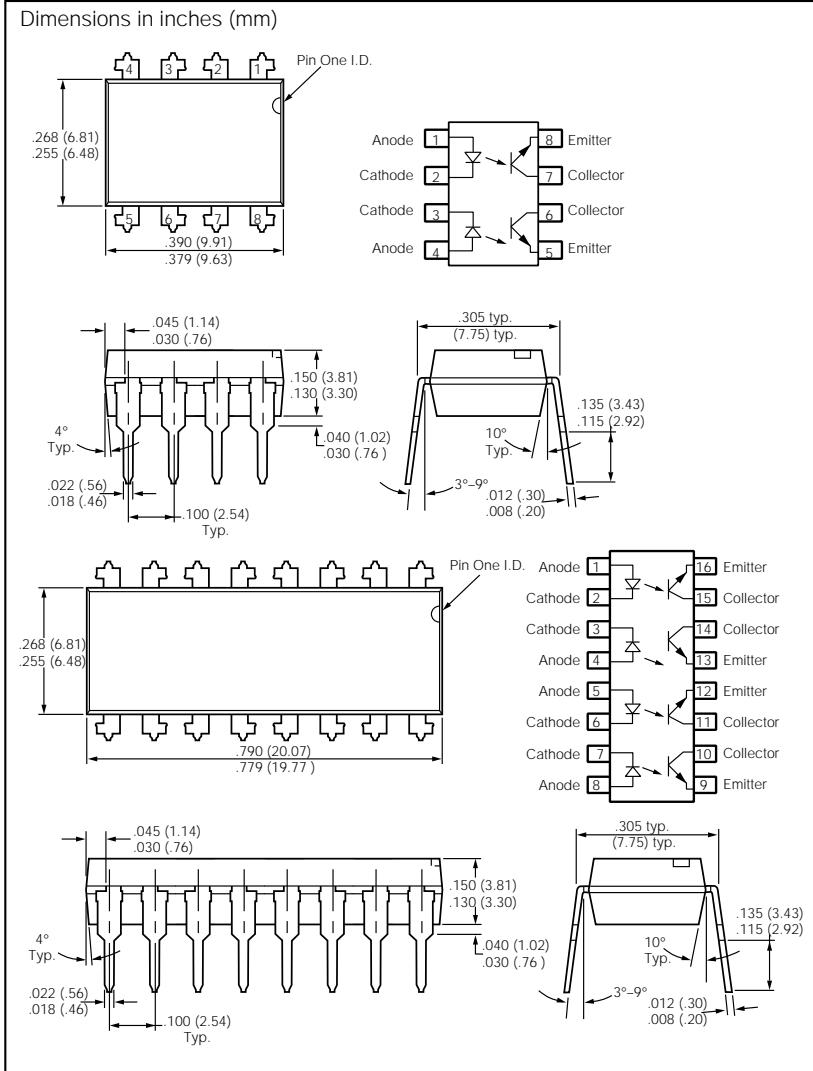
#### Detector

Collector-Emitter Reverse Voltage .....	70 V
Collector Current .....	50 mA
Collector Current ( $t < 1 \text{ ms}$ ).....	100 mA
Power Dissipation.....	150 mW
Derate from 25°C .....	-2 mW/°C

#### Package

##### Isolation Test Voltage

( $t=1 \text{ sec.}$ ) .....	7500 VAC <sub>PK</sub>
( $t=1 \text{ min.}$ ) .....	5300 VAC <sub>RMS</sub>
Package Dissipation ILD620/GB.....	400 mW
Derate from 25°C .....	5.33 mW/°C
Package Dissipation ILQ620/GB .....	500 mW
Derate from 25°C .....	6.67 mW/°C
Creepage .....	7 mm min.
Clearance.....	7 mm min.
Isolation Resistance	
$V_{IO}=500 \text{ V}, T_A=25^\circ\text{C}$ .....	$\geq 10^{12} \Omega$
$V_{IO}=500 \text{ V}, T_A=100^\circ\text{C}$ .....	$\geq 10^{11} \Omega$
Storage Temperature.....	-55°C to +150°C
Operating Temperature .....	-55°C to +100°C
Junction Temperature.....	100°C
Soldering Temperature	
(2 mm from case bottom) .....	260°C



### DESCRIPTION

The ILD/Q621 and ILD/Q621GB are multi-channel phototransistor optocouplers that use GaAs IRLED emitters and high gain NPN silicon phototransistors. These devices are constructed using over/under leadframe optical coupling and double molded insulation technology. This assembly process offers a withstand test voltage of 7500 VDC.

The ILD/Q621GB is well suited for CMOS interfacing given the  $CTR_{CEsat}$  of 30% minimum at  $I_F$  of 1 mA. High gain linear operation is guaranteed by a minimum  $CTR_{CE}$  of 100% at 5 mA. The ILD/Q621 has a guaranteed  $CTR_{CE}$  of 50% minimum at 5 mA. The TRansparent IOn Shield insures stable DC gain in applications such as power supply feedback circuits, where constant DC  $V_{IO}$  voltages are present.

## Characteristics

	<b>Symbol</b>	<b>Min.</b>	<b>Typ.</b>	<b>Max.</b>	<b>Unit</b>	<b>Condition</b>
<b>Emitter</b>						
Forward Voltage	$V_F$	1	1.15	1.3	V	$I_F=10 \text{ mA}$
Reverse Current	$I_R$		0.01	10	$\mu\text{A}$	$V_R=6 \text{ V}$
Capacitance	$C_O$		40		$\text{pF}$	$V_F=0 \text{ V}, f=1 \text{ MHz}$
Thermal Resistance, Junction to Lead	$R_{THJL}$		750		$^{\circ}\text{C/W}$	
<b>Detector</b>						
Capacitance	$C_{CE}$		6.8		$\text{pF}$	$V_{CE}=5 \text{ V}, f=1 \text{ MHz}$
Collector-Emitter Leakage Current	$I_{CEO}$		10	100	$\text{nA}$	$V_{CE}=24 \text{ V}$
Collector-Emitter Leakage Current	$I_{CEO}$		2	50	$\mu\text{A}$	$T_A=85^{\circ}\text{C}, V_{CE}=24 \text{ V}$
Thermal Resistance, Junction to Lead	$R_{THJL}$		500		$^{\circ}\text{C/W}$	
<b>Package Transfer Characteristics</b>						
Channel/Channel CTR Match	CTR/X/CTRY	1 to 1		3 to 1		$I_F=5 \text{ mA}, V_{CE}=5 \text{ V}$
<b>ILD/Q621</b>						
Saturated Current Transfer Ratio	$CTR_{CEsat}$		60		%	$I_F=1 \text{ mA}, V_{CE}=0.4 \text{ V}$
Current Transfer Ratio	$CTR_{CE}$	50	80	600	%	$I_F=5 \text{ mA}, V_{CE}=5 \text{ V}$
Collector-Emitter Saturation Voltage	$V_{CEsat}$			0.4	V	$I_F=8 \text{ mA}, I_{CE}=2.4 \text{ mA}$
<b>ILD/Q621GB</b>						
Saturated Current Transfer Ratio	$CTR_{CEsat}$	30			%	$I_F=1 \text{ mA}, V_{CE}=0.4 \text{ V}$
Current Transfer Ratio (Collector-Emitter)	$CTR_{CE}$	100	200	600	%	$I_F=5 \text{ mA}, V_{CE}=5 \text{ V}$
Collector-Emitter Saturation Voltage	$V_{CEsat}$			0.4	V	$I_F=8 \text{ mA}, I_{CE}=0.2 \text{ mA}$
<b>Isolation and Insulation</b>						
Common Mode Rejection, Output High	CMH		5000		$\text{V}/\mu\text{s}$	$V_{CM}=50 \text{ V}_{\text{P-P}}, R_L=1 \text{ k}\Omega, I_F=0 \text{ mA}$
Common Mode Rejection, Output Low	CML		5000		$\text{V}/\mu\text{s}$	$V_{CM}=50 \text{ V}_{\text{P-P}}, R_L=1 \text{ k}\Omega, I_F=10 \text{ mA}$
Common Mode Coupling Capacitance	$C_{CM}$		0.01		$\text{pF}$	
Package Capacitance	CI-O	0.8			$\text{pF}$	$V_{IO}=0 \text{ V}, f=1 \text{ MHz}$
Insulation Resistance	$R_s$	$10^{12}$			$\Omega$	$V_{IO}=500 \text{ V}, T_A=25^{\circ}\text{C}$
Channel to Channel Insulation		500			VAC	

## Switching Times

Figure 1. Non-saturated switching timing

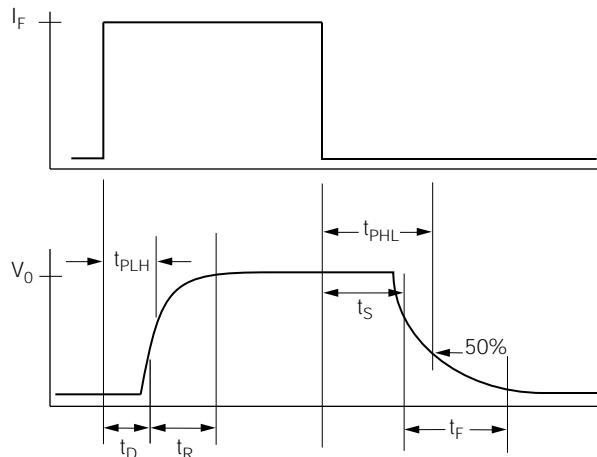
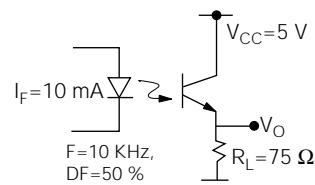
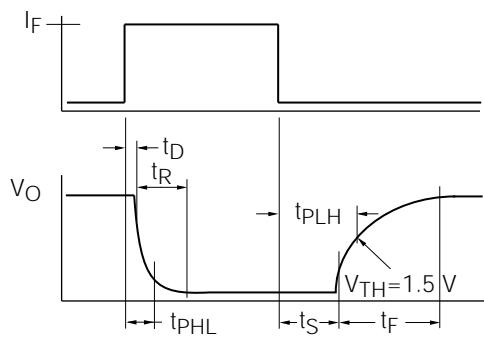


Figure 2. Non-saturated switching timing

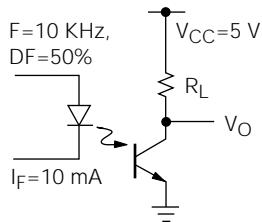


<b>Characteristic</b>	<b>Symbol</b>	<b>Typ.</b>	<b>Unit</b>	<b>Test Condition</b>
On Time	$T_{ON}$	3.0	$\mu\text{s}$	$I_F=\pm 10 \text{ mA}$
Rise Time	$t_R$	20	$\mu\text{s}$	$V_{CC}=5 \text{ V}$
Off Time	$t_{OFF}$	2.3	$\mu\text{s}$	$R_L=75 \Omega$
Fall Time	$t_F$	2.0	$\mu\text{s}$	50% of $V_{PP}$
Propagation H-L	$t_{PHL}$	1.1	$\mu\text{s}$	
Propagation L-H	$t_{PLH}$	2.5	$\mu\text{s}$	

**Figure 3. Saturated switching timing**

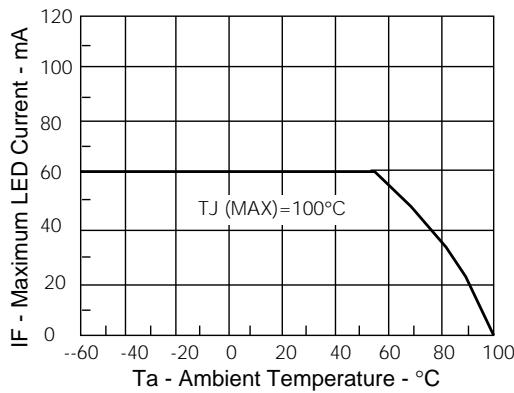


**Figure 4. Saturated switching timing**

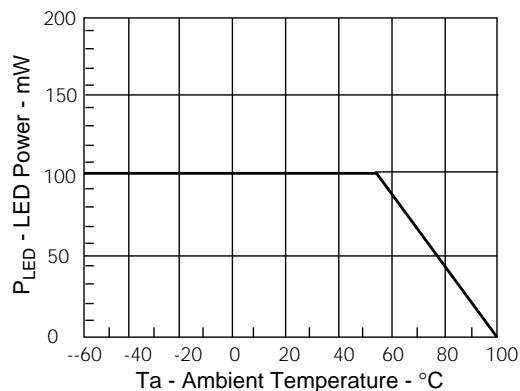


Characteristic	Symbol	Typ.	Unit	Test Condition
On Time	$T_{ON}$	4.3	$\mu s$	$I_F = \pm 10 \text{ mA}$ $V_{CC} = 5 \text{ V}$ $R_L = 1 \Omega$ $V_{TH} = 1.5 \text{ V}$
Rise Time	$t_R$	2.8	$\mu s$	
Off Time	$t_{OFF}$	2.5	$\mu s$	
Fall Time	$t_F$	11	$\mu s$	
Propagation H-L	$t_{PHL}$	2.6	$\mu s$	
Propagation L-H	$t_{PLH}$	7.2	$\mu s$	

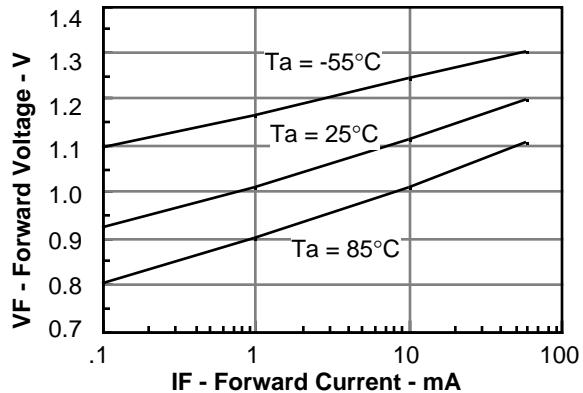
**Figure 5. Maximum LED current versus ambient temperature**



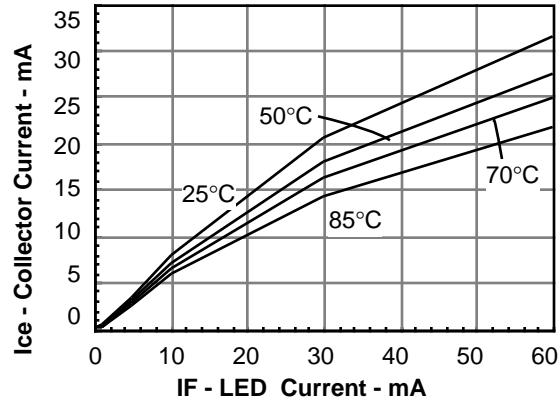
**Figure 6. Maximum LED power dissipation**



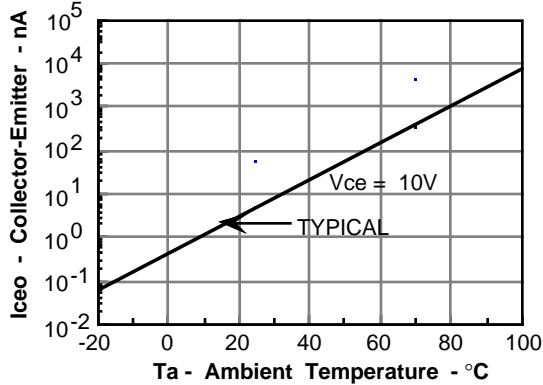
**Figure 7. Forward voltage versus forward current**



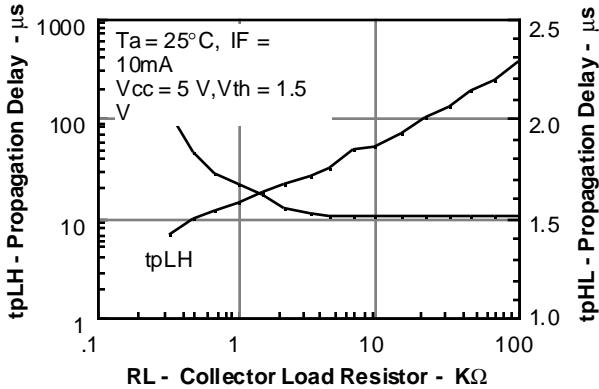
**Figure 8. Collector-emitter current versus temperature and LED current**



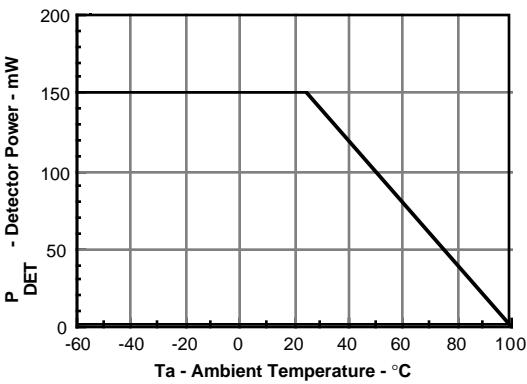
**Figure 9. Collector-emitter leakage versus temperature**



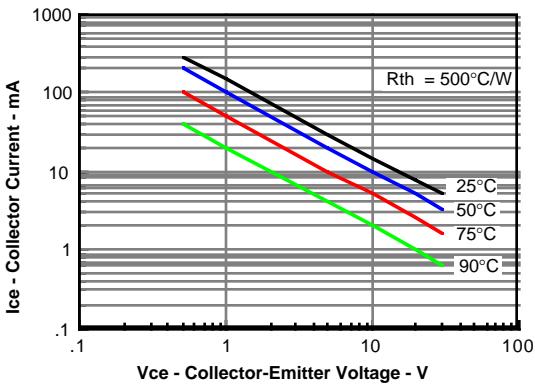
**Figure 10. Propagation delay versus collector load resistor**



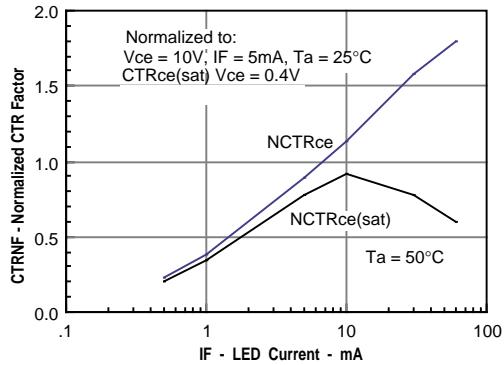
**Figure 11. Maximum detector power dissipation**



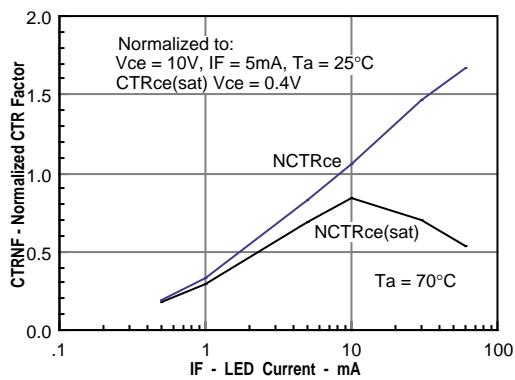
**Figure 12. Maximum collector current versus collector voltage**



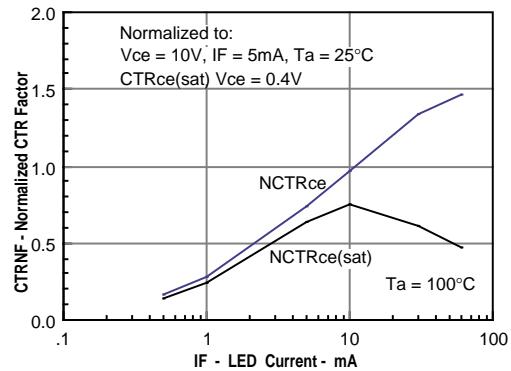
**Figure 13. Normalization factor for non-saturated and saturated CTR  $T_A=50^\circ\text{C}$  versus If**



**Figure 14. Normalization factor for non-saturated and saturated CTR  $T_A=70^\circ\text{C}$  versus If**



**Figure 15. Normalization factor for non-saturated and saturated CTR  $T_A=100^\circ\text{C}$  versus If**



**Figure 16. Peak LED current versus pulse duration,  $\tau$**

